## Search Notes

## \*10519006\*

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/519,006	SPECHT ET AL.	
Examiner	Art Unit	
LOIS ZHENG	1733	

	SEARCHED					
Class	Subclass	Date	Examiner			

INTERFERENCE SEARCHED				
Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)					
·	DATE	EXMR			
Inventorship search	12/30/2010	LLZ			
Updated EAST search	12/30/2010	LLZ			